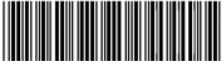


Search Notes



Application/Control No.

10/713,126

Examiner

SETH WEIS

Applicant(s)/Patent under Reexamination

FARRELL ET AL.

SEARCHED

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**